

DDR4 SDRAM ECC-UnBuffered DIMM

8GB based on 4Gbit (512Mx8) component



Revision 1.0 (SEPT., 2014)
-Initial Release



DDR4 SDRAM

1. Features

- Power Supply: VDD=1.2V (1.14V to 1.26V)
- VDDQ = 1.2V (1.14V to 1.26V)
- VPP 2.5V (2.375V to 2.75V)
- VDDSPD=2.25V to 2.75V
- Functionality and operations comply with the DDR4 SDRAM datasheet
- 16 internal banks
- Bank Grouping is applied, and CAS to CAS latency (tCCD_L, tCCD_S) for the banks in the same or different bank group
 accesses are available
- Data transfer rates: PC4-2133, PC4-1866, PC4-1600
- Bi-Directional Differential Data Strobe
- 8 bit pre-fetch
- Burst Length (BL) switch on-the-fly BL8 or BC4(Burst Chop)
- Supports ECC error correction and detection
- On-Die Termination (ODT)
- Temperature sensor with integrated SPD
- This product is in compliance with the RoHS directive.
- Per DRAM Addressability is supported
- Internal Vref DQ level generation is available
- Write CRC is supported at all speed grades
- DBI (Data Bus Inversion) is supported(x8)
- CA parity (Command/Address Parity) mode is supported

2. Ordering Information

Part Number	Density	Organization	Component Composition	# of Rank	Description
F21EB8GS	8GB	1Gx72	512Mx8 x 18pcs	2	PC4-17000

Note: Last character of the Part Number (x) represents DRAM vendor

S=Samsung; M=Micron; H=Hynix

3. Key Timing Parameters

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	DDR4-2133	Unit
CL-tRCD-tRP	15-15-15	tCK
CAS Latency	14.06	tCK
tCK(min)	0.93	ns
tRCD(min)	14.06	ns
tRP(min)	14.06	ns
tRAS(min)	33	ns
tRC(min)	47.06	ns

4. Address Configuration

Organization	Row Address	Column Address	Bank Address	Bank Group Address	Auto Pre- Charge
512Mx8(4Gb) base	A0-A14	A0-A9	BA0-BA1	BG0-BG1	A10/AP



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5. DIMM Pin Descriptions

The pin description table below is a comprehensive list of all possible pins for all DDR4 modules. Pins listed below may not be all supported on this module. Please see Pin Assignments for information specific to this module.

Pin Name	Description	Pin Name	Description
A0-A17 ¹	Register address input	SCL	I ² C serial bus clock for SPD/TS and register
BA0, BA1	Register bank select input	SDA	I ² C serial data line for SPD/TS and register
BG0, BG1	Register bank group select input	SA0-SA2	I ² C slave address select for SPD/TS and register
RAS_n ²	Register row address strobe input	PAR	Register parity input
CAS_n ³	Register column address strobe input	VDD	SDRAM core power
WE_n ⁴	Register write enable input		
CS0_n, CS1_n,	DIMM Rank Select Lines input	12V	Optional power supply on socket but not used
CS2_n, CS3_n	-		on RDIMM
CKE0, CEK1	Register clock enable lines input	VREFCA	SDRAM command/address reference supply
ODT0, ODT1	Register on-die termination control	VSS	Power supply return (ground)
	lines input		
ACT_n	Register input for activate input	VDDSPD	Serial SPD/TS positive power supply
DQ0-DQ63	DIMM memory data bus	ALERT_n	Register ALERT_n output
CB0-CB7	DIMM ECC check bits	VPP	SDRAM Supply
TDQS9_t-TDQS17_t	Dummy loads for mixed populations		
TDQS_c-TDQS17_c	of x4 based and x8		
DQS0_t-DQS17_t	Data Buffer data strobes (positive line	RESET_n	Set Register and SDRAMs to a Known State
	of differential pair)		
DBI0_n-DBI8_n	Data Bus Inversion	EVENT_n	SPD signals a thermal event has occurred
CK0_t, CK1_t	Register clock input (positive line of	VTT	SDRAM I/O termination supply
CVO a CV1 a	differential pair)	DELL	Decemend for future use
CK0_c, CK1_c	Register clock input (negative line of differential pair)	RFU	Reserved for future use

- 1. Addrewss A17 is only valid for 16Gbx4 based SDRAMs.
- 2. RAS_n is a multiplexed function with A16
- 3. CAS_n is a multiplexed function with A15
- 4. WE_n is a multiplexed function with A14

6. Input/Output Functional Descriptions

Symbol	Туре	Function
CK_t, CK_c	Input	Clock: CK_t and CK_c are differential clock inputs. All address and control input signals are
		sampled on the crossing of the positive edge of CK_t and negative edge of CK_c.
CKE, (CKE1)	Input	Clock Enable: CKE HIGH activates, and CKE Low deactivates, internal clock signals and device input buffers and output drivers. Taking CKE Low provides Precharge Power-Down and Self-Refresh operation (all banks idle), or Active Power-Down (row Active in any bank). CKE is asynchronous for Self-Refresh exit. After VREFCA and VREFDQ have become stable during the power on and initialization sequence, they must be maintained during all operations (including Self-Refresh). CKE must be maintained highthroughout read and write accesses. Input buffers, excluding CK, CK_c, ODT, and CKE, are disabled during power-down. Input buffers, excluding CKE, are disabled during Self-Refresh.
CS_n, (CS1_n)	Input	Chip Select: All commands are masked when CS_n is registered HIGH. CS_n provides for external Rank selection on systems with multiple Ranks. CS_n is considered part of the command code.
C0,C1,C2	Input	Chip ID: Chip ID is only used for 3DS for 2, 4, 8high stack via TSV to select each slice of stacked component. Chip ID is considered part of the command code.



Symbol	Туре	Function
ODT, (ODT1)	Input	On Die Termination: ODT (registered HIGH) enables termination resistance internal to the DDR4 SDRAM. When enabled, ODT is only applied to each DQ, DQS_t, DQS_c and DM_n/DBI_n/TDQS_t,NU/TDQS_c (When TDQS is enabled via Mode Register A11=1 in MR1) signal for x8 configurations. For x16 configuration ODT is applied to each DQ, DQSU_c, DQSU_t, DQSL_t, DQSL_c, DMU_n, and DML_n signal. The ODT pin will be ignored if MR1 is programmed to disable RTT_NOM.
ACT_n	Input	Activation Command Input: ACT_n defines the Activation command being entered along with CS_n. The input into RAS_n/A16, CAS_n/A15 and WE_n/A14 will be considered as Row Address A16, A15 and A14.
RAS_n/A16, CAS_n/A15, WE_n/A14	Input	Command Inputs RAS_n/A16, CAS_n/A15 and WE_n/A14 (along with CS_n) define the command being entered. Those pins have multifunction. For example, for activation with ACT_n Low, those are Addressing like A16, A15 and A14 but for non-activation command with ACT_n High, those are Command pins for Read, Write and other command defined in command truth table.
DM_n/DBI_n/ TDQS_t, (DMU_n/DBIU_n), (DML_n/DBIL_n)	Input / Output	Input Data Mask and Data Bus Inversion: DM_n is an input mask signal for write data. Input data is masked when DM_n is sampled LOW coincident with that input data during a Write access. DM_n is sampled on both edges of DQS. DM is muxed with DBI function by Mode Register A10, A11, A12 setting in MR5. For x8 device, the function of DM or TDQS is enabled by Mode Register A11 setting in MR1. DBI_n is an input/output identifying whether to store/output the true or inverted data. If DBI_n is LOW, the data will be stored/output after inversion inside the DDR4 SDRAM and not inverted if DBI_n is HIGH. TDQS is only supported in x8.
BG0 - BG1	Input	Bank Group Inputs: BG0 - BG1 define to which bank group an Active, Read, Write or Precharge command is being applied. BG0 also determines which mode register is to be accessed during a MRS cycle. x4/8 have BG0 and BG1 but x16 has only BG0.
BA0 - BA1	Input	Bank Address Inputs: BA0 - BA1 define to which bank an Active, Read, Write or Precharge command is being applied. Bank address also determines if the mode register or extended mode register is to be accessed during a MRS cycle.
A0 - A17	Input	Address Inputs: Provided the row address for ACTIVATE Commands and the column address for Read/Write commands to select one location out of the memory array in the respective bank. (A10/AP, A12/BC_n, RAS_n/A16, CAS_n/A15 and WE_n/A14 have additional functions, see other rows. The address inputs also provide the op-code during Mode Register Set commands. A17 is only defined for the x4 configuration.
A10 / AP	Input	Auto-precharge: A10 is sampled during Read/Write commands to determine whether Auto-precharge should be performed to the accessed bank after the Read/Write operation. (HIGH: Auto-precharge; LOW: no Auto-precharge). A10 is sampled during a Precharge command to determine whether the Precharge applies to one bank (A10 LOW) or all banks (A10 HIGH). If only one bank is to be precharged, the bank is selected by bank addresses.
A12 / BC_n	Input	Burst Chop: A12 / BC_n is sampled during Read and Write commands to determine if burst chop (on-the-fly) will be performed. (HIGH, no burst chop; LOW: burst chopped). See command truth table for details.
RESET_n	Input	Active Low Asynchronous Reset: Reset is active when RESET_n is LOW, and inactive when RESET_n is HIGH. RESET_n must be HIGH during normal operation. RESET_n is a CMOS rail to rail signal with DC high and low at 80% and 20% of VDD.



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Symbol	Туре	Function
DQ	Input/	Data Input/ Output: Bi-directional data bus. If CRC is enabled via Mode register then CRC
	Output	code is added at the end of Data Burst. Any DQ from DQ0~DQ3 may indicate the internal
		Vref level during test via Mode Register Setting MR4 A4=High. Refer to vendor specific
DOC + DOC -	To much /	datasheets to determine which DQ is used.
DQS_t, DQS_c, DQSU_t, DQSU_c,	Input/ Output	Data Strobe: output with read data, input with write data. Edge-aligned with read data,
DQSU_t, DQSU_c,	Output	centered in write data. For x16, DQSL corresponds to the data on DQL0-DQL7; DQSU corresponds to the data on DQU0-DQU7. The data strobe DQS_t, DQSL_t, and DQSU_t are
DQ3L_t, DQ3L_t		paired with differential signals DQS_c, DQSL_c, and DQSU_c, respectively, to provide
		differential pair signaling to the system during reads and writes. DDR4 SDRAM supports
		differential data strobe only and does not support single-ended.
TDQS_t, TDQS_c	Output	Termination Data Strobe: TDQS_t/TDQS_c is applicable for x8 DRAMs only. When enabled
		via Mode Register A11 = 1 in MR1, the DRAM will enable the same termination resistance
		function on TDQS_t/TDQS_c that is applied to DQS_t/DQS_c. When disabled via mode
		register A11 = 0 in MR1, DM/DBI/TDQS will provide the data mask function or Data Bus
		Inversion depending on MR5; A11, 12, 10 and TDQS_c is not used. x4/x16
PAR	Input	DRAMs must disable the TDQS function via mode register A11 = 0 in MR1.
FAR	Input	Command and Address Parity Input: DDR4 Supports Even Parity check in DRAMs with MR setting. Once it's enabled via Register in MR5, then DRAM calculates Parity with ACT_n,
		RAS_n/A16, CAS_n/A15, WE_n/A14, BG0-BG1, BA0-BA1, A17-A0. Input parity should
		maintain at the rising edge of the clock and at the same time with command & address
		with CS_n LOW.
ALERT_n	Output	Alert: It has multi functions such as CRC error flag, Command and Address Parity error
		flag. If there is error in CRC, then Alert_n goes LOW for the period time interval and goes
		back HIGH. IF there is error in Command Address Parity Check, then Alert_n goes LOW for
	<u>.</u>	relatively long period until ongoing DRAM internal recovery transaction to complete.
TEN	Input	Connectivity Test Mode Enable: Required on x16 devices and optional input on x4/x8 with
		densities equal to or greater than 8Gb. HIGH in this pin will enable boundary scan
		operation along with other pins. It is a CMOS rail to rail signal with DC high and low at 80% and 20% of VDD.
NC		No Connect: No internal electrical connection is present.
V _{DDQ}	Supply	DQ Power Supply: 1.2 V +/- 0.06 V
V _{SSQ}	Supply	DQ Ground
V_{DD}	Supply	Power Supply: 1.2 V +/- 0.06 V
V_{SS}	Supply	Ground
V_{PP}	Supply	DRAM Activation Power Supply: 2.5V (2.375V min , 2.75 max)
V_{REFCA}	Supply	Reference voltage for CA
ZQ	Supply	Reference Pin for ZQ calibration

Note: Input only pins (BG0-BG-1, BA0-BA1, A0-A17, ACT_n, RAS_n,/A16, CAS_n/A15, WE_n/A14, CS_n, CKE, ODT, and RESET_n) do not supply termination.



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7. Pin Assignments

ASSIG	IIIIIciits			•			
Pin	Front Side Pin Label	Pin	Back Side Pin Label	Pin	Front Side Pin Label	Pin	Back Side Pin Label
1	12V , NC	145	12V , NC	74	CK0_t	218	CK1_t
2	VSS	146	VREFCA	75	CK0_c	219	CK1_c
3	DQ4	147	VSS	76	VDD	220	VDD
4	VSS	148	DQ5	77	VTT	221	VTT
5	DQ0	149	VSS		V	EY	
6	VSS	150	DQ1	1	K	L I	
7	TDQS9_t, DQS9_t, DM0_n, DBI0_n	151	VSS	78	EVENT_n	222	PARITY
8	TDQS9_c, DQS9_c, NC	152	DQS0_c	79	A0	223	VDD
9	VSS	153	DQS0_t	80	VDD	224	BA1
10	DQ6	154	VSS	81	BA0	225	A10/AP
11	VSS	155	DQ7	82	RAS_n/A16	226	VDD
12	DQ2	156	VSS	83	VDD	227	RFU
13	VSS	157	DQ3	84	CS0_n	228	WE_n/A14
14	DQ12	158	VSS	85	VDD	229	VDD
15	VSS	159	DQ13	86	CAS_n/A15	230	NC, SAVE_n
16	DQ8	160	VSS	87	ODT0	231	VDD
17	VSS	161	DQ9	88	VDD	232	A13
18	TDQS10_t, DQS10_t, DM1_n, DBI1_n	162	VSS	89	CS1_n, NC	233	VDD
19	TDQS10_c, DQS10_c,	163	DQS1_c	90	VDD	234	NC, A17
20	VSS	164	DQS1_t	91	ODT1, NC	235	NC, C2
21	DQ14	165	VSS	92	VDD	236	VDD
22	VSS	166	DQ15	93	C0, CS2_n, NC	237	NC, CS3_n, C1
23	DQ10	167	VSS	94	VSS	238	SA2
24	VSS	168	DQ11	95	DQ36	239	VSS
25	DQ20	169	VSS	96	VSS	240	DQ37
26	VSS	170	DQ21	97	DQ32	241	VSS
27	DQ16	171	VSS	98	VSS	242	DQ33
28	VSS	172	DQ17	99	TDQS13_t, DQS13_t, DM4_n, DBI4_n	243	VSS
29	TDQS11_t, DQS11_t, DM2_n, DBI2_n	173	VSS	100	TDQS13_c, DQS13_c, NC	244	DQS4_c
30	TDQS11_c, DQS11_c,	174	DQS2_c	101	VSS	245	DQS4_t
31	VSS	175	DQS2_t	102	DQ38	246	VSS
32	DQ22	176	VSS	103	VSS	247	DQ39
33	VSS	177	DQ23	104	DQ34	248	VSS
34	DQ18	178	VSS	105	VSS	249	DQ35

Note: Light colored text indicates functions that are not applicable for this design. An example is the NC for pin 56 because the products defined by this specification will always have DIMM wiring for this pin.



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35	Pin	Front Side Pin Label	Pin	Back Side Pin Label	Pin	Front Side Pin Label	Pin	Back Side Pin Label
37	35	VSS	179	DQ19	106	DQ44	250	VSS
38	36	DQ28	180	VSS	107	VSS	251	DQ45
39	37	VSS	181	DQ29	108	DQ40	252	VSS
TDQS12_t, DQS12_t, 184	38	DQ24	182	VSS	109	VSS	253	DQ41
10	39	VSS	183	DQ25	110		254	VSS
1	40		184	VSS	111		255	DQS5_c
43	41		185	DQS3_c	112	VSS	256	DQS3_t
44 VSS 188 DQ31 115 DQ42 259 VSS 45 DQ26 189 VSS 116 VSS 260 DQ43 46 VSS 190 DQ27 117 DQ52 261 VSS 47 CB4, NC 191 VSS 118 VSS 262 DQ53 48 VSS 192 CB5, NC 119 DQ48 263 VSS 49 CB0, NC 193 VSS 120 VSS 264 DQ49 50 VSS 194 CB1, NC 121 TDQ515_t, DQ515_t, DQ5	42	VSS	186	DQS3_t	113	DQ46	257	VSS
45 DQ26 189 VSS 116 VSS 260 DQ43 46 VSS 190 DQ27 117 DQ52 261 VSS 47 CB4, NC 191 VSS 118 VSS 262 DQ53 48 VSS 192 CB5, NC 119 DQ48 263 VSS 49 CB0, NC 193 VSS 120 VSS 264 DQ49 50 VSS 194 CB1, NC 121 TDQ515_t, DQ515_t, DQ	43	DQ30	187	VSS	114	VSS	258	DQ47
46 VSS 190 DQ27 117 DQ52 261 VSS 47 CB4, NC 191 VSS 118 VSS 262 DQ53 48 VSS 192 CB5, NC 119 DQ48 263 VSS 49 CB0, NC 193 VSS 120 VSS 264 DQ49 50 VSS 194 CB1, NC 121 TDQS15, DQS15_t, DGS15_t, DGS16_t, DGS	44	VSS	188	DQ31	115	DQ42	259	VSS
47 CB4, NC 191 VSS 118 VSS 262 DQ53 48 VSS 192 CB5, NC 119 DQ48 263 VSS 49 CB0, NC 193 VSS 120 VSS 264 DQ49 50 VSS 194 CB1, NC 121 TDQS15_t, DQS15_t, DQS15_t, DQS15_t, DQS15_t, DM6_n, DB18_n 265 VSS 51 TDQS17_t, DQS17_t, DQS17_c, DB18_n 195 VSS 122 TDQS15_c, DQS15_c, DQS15_c, DQS6_c 266 DQS6_c 52 TDQS17_c, DQS17_c, DQS17_c, DQS17_c, DQS8_t 124 DQ54 268 VSS 53 VSS 197 DQS8_t 124 DQ54 268 VSS 54 CB6, NC 198 VSS 125 VSS 269 DQ55 55 VSS 199 CB7, NC 126 DQ50 270 VSS 56 CB2, NC 200 VSS 127 VSS 271 DQ51 57 <td>45</td> <td>DQ26</td> <td>189</td> <td>VSS</td> <td>116</td> <td>VSS</td> <td>260</td> <td>DQ43</td>	45	DQ26	189	VSS	116	VSS	260	DQ43
48 VSS 192 CBS, NC 119 DQ48 263 VSS 49 CB0, NC 193 VSS 120 VSS 264 DQ49 50 VSS 194 CB1, NC 121 TDQS15_t, DQS15_t, DQS15_t, DQS15_t, DQS15_t, DM6_n, DB18_n 265 VSS 51 TDQS17_t, DQS17_t, DB18_n 195 VSS 122 TDQS15_c, DQS15_c, DQS15_c, DQS15_c, DQS6_t 266 DQS6_c 52 TDQS17_c, DQS17_c, DQS17_c, DQS8_t 124 DQS4 268 VSS 53 VSS 197 DQS8_t 124 DQ54 268 VSS 54 CB6, NC 198 VSS 125 VSS 269 DQ55 55 VSS 199 CB7, NC 126 DQ50 270 VSS 56 CB2, NC 200 VSS 127 VSS 271 DQ51 57 VSS 201 CB3, NC 128 DQ60 272 VSS 58	46	VSS	190	DQ27	117	DQ52	261	VSS
49 CB0, NC 193 VSS 120 VSS 264 DQ49 50 VSS 194 CB1, NC 121 TDQS15_t, DQS15_t, DS15_t, DM6_n, DB16_n 265 VSS 51 TDQS17_t, DQS17_t, DM8_n, DB18_n 195 VSS 122 TDQS15_c, DQS15_c, DQS15_c, DQS6_t 266 DQS6_c 52 TDQS17_c, DQS17_c, DQS17_c, NC 196 DQS8_c 123 VSS 267 DQS6_t 53 VSS 197 DQS8_t 124 DQ54 268 VSS 54 CB6, NC 198 VSS 125 VSS 269 DQ55 55 VSS 199 CB7, NC 126 DQ50 270 VSS 56 CB2, NC 200 VSS 127 VSS 271 DQ51 57 VSS 201 CB3, NC 128 DQ60 272 VSS 58 RESET_n 202 VSS 129 VSS 273 DQ61	47	CB4, NC	191	VSS	118	VSS	262	DQ53
50 VSS 194 CB1, NC 121 TDQS15_t, DQS15_t, DQS15_t, DM6_n, DB16_n 265 VSS 51 TDQS17_t, DQS17_t, DM8_n, DB18_n 195 VSS 122 TDQS15_c, DQS15_c, DQS15_c, DQS6_c 266 DQS6_c 52 TDQS17_c, DQS17_c, NC 196 DQS8_c 123 VSS 267 DQS6_t 53 VSS 197 DQS8_t 124 DQ54 268 VSS 54 CB6, NC 198 VSS 125 VSS 269 DQ55 55 VSS 199 CB7, NC 126 DQ50 270 VSS 56 CB2, NC 200 VSS 127 VSS 271 DQ51 57 VSS 201 CB3, NC 128 DQ60 272 VSS 58 RESET_n 202 VSS 129 VSS 273 DQ61 59 VDD 203 CKE1, NC 130 DQ56 274 VSS <td< td=""><td>48</td><td>VSS</td><td>192</td><td>CB5, NC</td><td>119</td><td>DQ48</td><td>263</td><td>VSS</td></td<>	48	VSS	192	CB5, NC	119	DQ48	263	VSS
SO	49	CB0, NC	193	VSS	120	VSS	264	DQ49
DMS_n, DBIS_n DQSS_c DQS	50	VSS	194	CB1, NC	121		265	VSS
52 NC 190 DQSs_C 123 VSS 207 DQSs_C 53 VSS 197 DQS8_t 124 DQ54 268 VSS 54 CB6, NC 198 VSS 125 VSS 269 DQ55 55 VSS 199 CB7, NC 126 DQ50 270 VSS 56 CB2, NC 200 VSS 127 VSS 271 DQ51 57 VSS 201 CB3, NC 128 DQ60 272 VSS 58 RESET_n 202 VSS 129 VSS 273 DQ61 59 VDD 203 CKE1, NC 130 DQ56 274 VSS 60 CKE0 204 VDD 131 VSS 275 DQ57 61 VDD 205 RFU 132 TDQS16_t, DQS16_t, DQS1	51		195	VSS	122		266	DQS6_c
54 CB6, NC 198 VSS 125 VSS 269 DQ55 55 VSS 199 CB7, NC 126 DQ50 270 VSS 56 CB2, NC 200 VSS 127 VSS 271 DQ51 57 VSS 201 CB3, NC 128 DQ60 272 VSS 58 RESET_n 202 VSS 129 VSS 273 DQ61 59 VDD 203 CKE1, NC 130 DQ56 274 VSS 60 CKE0 204 VDD 131 VSS 275 DQ57 61 VDD 205 RFU 132 TDQ516_t, DQS16_t, DQS16_t	52		196	DQS8_c	123	VSS	267	DQS6_t
55 VSS 199 CB7, NC 126 DQ50 270 VSS 56 CB2, NC 200 VSS 127 VSS 271 DQ51 57 VSS 201 CB3, NC 128 DQ60 272 VSS 58 RESET_n 202 VSS 129 VSS 273 DQ61 59 VDD 203 CKE1, NC 130 DQ56 274 VSS 60 CKE0 204 VDD 131 VSS 275 DQ57 61 VDD 205 RFU 132 TDQS16_t, DQS16_t, DQS16_t, DQS16_t, DMT_n, DBI7_n 276 VSS 62 ACT_n 206 VDD 133 TDQS15_t, DQS_c, DS_c, DQS7_c 277 DQS7_c 63 BG0 207 BG1 134 VSS 278 DQS7_t 64 VDD 208 ALERT_n 135 DQ62 279 VSS 65 A12/BC_n 209	53	VSS	197	DQS8_t	124	DQ54	268	VSS
56 CB2, NC 200 VSS 127 VSS 271 DQ51 57 VSS 201 CB3, NC 128 DQ60 272 VSS 58 RESET_n 202 VSS 129 VSS 273 DQ61 59 VDD 203 CKE1, NC 130 DQ56 274 VSS 60 CKE0 204 VDD 131 VSS 275 DQ57 61 VDD 205 RFU 132 TDQS16_t, DQS16_t, DQS16_t, DQS16_t, DM7_n, DB17_n 276 VSS 62 ACT_n 206 VDD 133 TDQS15_t, DQS_c, DM7_n, DB17_n 276 VSS 63 BG0 207 BG1 134 VSS 278 DQS7_c 64 VDD 208 ALERT_n 135 DQ62 279 VSS 65 A12/BC_n 209 VDD 136 VSS 280 DQ63 66 A9 210	54	CB6, NC	198	VSS	125	VSS	269	DQ55
57 VSS 201 CB3, NC 128 DQ60 272 VSS 58 RESET_n 202 VSS 129 VSS 273 DQ61 59 VDD 203 CKE1, NC 130 DQ56 274 VSS 60 CKE0 204 VDD 131 VSS 275 DQ57 61 VDD 205 RFU 132 TDQS16_t, DQS16_t, DQS16_t, DM7_n, DBI7_n 276 VSS 62 ACT_n 206 VDD 133 TDQS15_t, DQS_c, DQS_c, DQS7_c 277 DQS7_c 63 BG0 207 BG1 134 VSS 278 DQS7_t 64 VDD 208 ALERT_n 135 DQ62 279 VSS 65 A12/BC_n 209 VDD 136 VSS 280 DQ63 66 A9 210 A11 137 DQ58 281 VSS 67 VDD 211 <td< td=""><td>55</td><td>VSS</td><td>199</td><td>CB7, NC</td><td>126</td><td>DQ50</td><td>270</td><td>VSS</td></td<>	55	VSS	199	CB7, NC	126	DQ50	270	VSS
58 RESET_n 202 VSS 129 VSS 273 DQ61 59 VDD 203 CKE1, NC 130 DQ56 274 VSS 60 CKE0 204 VDD 131 VSS 275 DQ57 61 VDD 205 RFU 132 TDQS16_t, DQS16_t, DQS16_t, DQS16_t, DM7_n, DB17_n 276 VSS 62 ACT_n 206 VDD 133 TDQS15_t, DQS_c, NC 277 DQS7_c 63 BG0 207 BG1 134 VSS 278 DQS7_t 64 VDD 208 ALERT_n 135 DQ62 279 VSS 65 A12/BC_n 209 VDD 136 VSS 280 DQ63 66 A9 210 A11 137 DQ58 281 VSS 67 VDD 211 A7 138 VSS 282 DQ59	56	CB2, NC	200	VSS	127	VSS	271	DQ51
59 VDD 203 CKE1, NC 130 DQ56 274 VSS 60 CKE0 204 VDD 131 VSS 275 DQ57 61 VDD 205 RFU 132 TDQS16_t, DQS16_t, DQS16_t, DQS16_t, DQS16_t, DQS1_c, DM7_n, DBI7_n 276 VSS 62 ACT_n 206 VDD 133 TDQS15_t, DQS_c, NC 277 DQS7_c 63 BG0 207 BG1 134 VSS 278 DQS7_t 64 VDD 208 ALERT_n 135 DQ62 279 VSS 65 A12/BC_n 209 VDD 136 VSS 280 DQ63 66 A9 210 A11 137 DQ58 281 VSS 67 VDD 211 A7 138 VSS 282 DQ59	57	VSS	201	CB3, NC	128	DQ60	272	VSS
60 CKE0 204 VDD 131 VSS 275 DQ57 61 VDD 205 RFU 132 TDQS16_t, DQS16_t, DQS16_t, DRST_n 276 VSS 62 ACT_n 206 VDD 133 TDQS15_t, DQS_c, DQS_c, DQS7_c 277 DQS7_c 63 BG0 207 BG1 134 VSS 278 DQS7_t 64 VDD 208 ALERT_n 135 DQ62 279 VSS 65 A12/BC_n 209 VDD 136 VSS 280 DQ63 66 A9 210 A11 137 DQ58 281 VSS 67 VDD 211 A7 138 VSS 282 DQ59	58	RESET_n	202	VSS	129	VSS	273	DQ61
61 VDD 205 RFU 132 TDQS16_t, DQS16_t, DQS16_t, DM7_n, DBI7_n 276 VSS 62 ACT_n 206 VDD 133 TDQS15_t, DQS_c, NC 277 DQS7_c 63 BG0 207 BG1 134 VSS 278 DQS7_t 64 VDD 208 ALERT_n 135 DQ62 279 VSS 65 A12/BC_n 209 VDD 136 VSS 280 DQ63 66 A9 210 A11 137 DQ58 281 VSS 67 VDD 211 A7 138 VSS 282 DQ59	59	VDD	203	CKE1, NC	130	DQ56	274	VSS
61 VDD 203 RFO 132 DM7_n, DB17_n 276 VSS 62 ACT_n 206 VDD 133 TDQS15_t, DQS_c, NC 277 DQS7_c 63 BG0 207 BG1 134 VSS 278 DQS7_t 64 VDD 208 ALERT_n 135 DQ62 279 VSS 65 A12/BC_n 209 VDD 136 VSS 280 DQ63 66 A9 210 A11 137 DQ58 281 VSS 67 VDD 211 A7 138 VSS 282 DQ59	60	CKE0	204	VDD	131	VSS	275	DQ57
62 ACT_III 200 VBD 133 NC 277 BQ37_C 63 BG0 207 BG1 134 VSS 278 DQ57_t 64 VDD 208 ALERT_n 135 DQ62 279 VSS 65 A12/BC_n 209 VDD 136 VSS 280 DQ63 66 A9 210 A11 137 DQ58 281 VSS 67 VDD 211 A7 138 VSS 282 DQ59	61	VDD	205	RFU	132		276	VSS
64 VDD 208 ALERT_n 135 DQ62 279 VSS 65 A12/BC_n 209 VDD 136 VSS 280 DQ63 66 A9 210 A11 137 DQ58 281 VSS 67 VDD 211 A7 138 VSS 282 DQ59	62	ACT_n	206	VDD	133		277	DQS7_c
65 A12/BC_n 209 VDD 136 VSS 280 DQ63 66 A9 210 A11 137 DQ58 281 VSS 67 VDD 211 A7 138 VSS 282 DQ59	63	BG0	207	BG1	134	VSS	278	DQS7_t
66 A9 210 A11 137 DQ58 281 VSS 67 VDD 211 A7 138 VSS 282 DQ59	64	VDD	208	ALERT_n	135	DQ62	279	VSS
67 VDD 211 A7 138 VSS 282 DQ59	65	A12/BC_n	209	VDD	136	VSS	280	DQ63
	66	A9	210	A11	137	DQ58	281	VSS
69 A9 213 A5 120 CAO 202 VCC	67	VDD	211	A7	138	VSS	282	DQ59
OO	68	A8	213	A5	139	SA0	283	VSS

Note: Light colored text indicates functions that are not applicable for this design. An example is the NC for pin 56 because the products defined by this specification will always have DIMM wiring for this pin.



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Pin	Front Side Pin Label	Pin	Back Side Pin Label	Pin	Front Side Pin Label	Pin	Back Side Pin Label
69	A6	214	A4	140	SA1	284	VDDSPD
70	VDD	215	VDD	141	SCL	285	SDA
71	A3	215	VDD	142	VPP	286	VPP
72	A1	216	A2	143	VPP	287	VPP
73	VDD	217	VDD	144	RFU	288	VPP

Note: Light colored text indicates functions that are not applicable for this design. An example is the NC for pin 56 because the products defined by this specification will always have DIMM wiring for this pin.

8. Absolute Maximum DC Ratings

Symbol	Parameter	Rating	Units	NOTE
VDD	Voltage on VDD pin relative to Vss	-0.3 ~ 1.5	V	1,3
VDDQ	Voltage on VDDQ pin relative to Vss	-0.3 ~ 1.5	V	1,3
VPP	Voltage on VPP pin relative to Vss	-0.3 ~ 3.0	V	4
V _{IN} , V _{OUT}	Voltage on any pin relative to Vss	-0.3 ~ 1.5	V	1
T _{STG}	Storage Temperature	-55 to +100	°C	1,2

Note:

- 1. Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability
- 2. Storage Temperature is the case surface temperature on the center/top side of the DRAM. For the measurement conditions, please refer to JESD51-2 standard.
- 3. VDD and VDDQ must be within 300 mV of each other at all times; and VREFCA must be not greater than 0.6 x VDDQ. When VDD and VDDQ are less than 500 mV; VREF may be equal to or less than 300 mV
- 4. VPP must be equal or greater than VDD/VDDQ at all times

9. DRAM Component Operating Temperature Range

Symbol	Parameter	Rating	Units	NOTE
т	Normal Operating Temperature Range	0 to 85	°C	1,2
OPER	Extended Temperature Range	85 to 95	°C	1,3

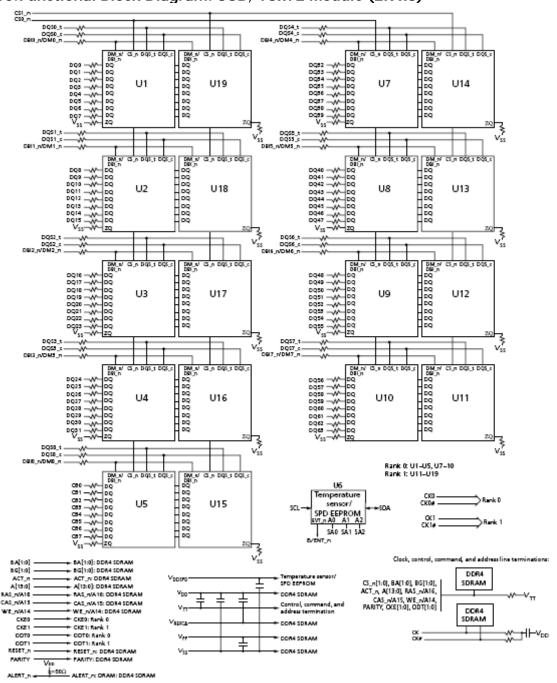
Note:

- Operating Temperature TOPER is the case surface temperature on the center / top side of the DRAM. For mea- surement conditions, please refer to the JEDEC document JESD51-2.
- 2. The Normal Temperature Range specifies the temperatures where all DRAM specifications will be supported. Dur- ing operation, the DRAM case temperature must be maintained between 0 85°C under all operating conditions.
- 3. Some applications require operation of the DRAM in the Extended Temperature Range between 85°C and 95°C case temperature. Full specifications are quaranteed in this range, but the following additional conditions apply:
 - a. Refresh commands must be doubled in frequency, therefore reducing the Refresh interval tREFI to 3.9 µs. It is also possible to specify a component with 1X refresh (tREFI to 7.8µs) in the Extended Temperature Range. Please refer to the DIMM SPD for option availability
 - b. If Self-Refresh operation is required in the Extended Temperature Range, then it is mandatory to either use the Manual Self-Refresh mode with Extended Temperature Range capability (MR2 A6 = 0b and MR2 A7 = 1b) or enable the optional Auto Self-Refresh mode (MR2 A6 = 1b and MR2 A7 = 0b). DDR4 SDRAMs support Auto Self-Refresh and in Extended Temperature Range and please refer to component datasheet and/or the DIMM SPD for tREFI requirements in the Extended Temperature Range



DDR4 SDRAM

10. Functional Block Diagram: 8GB; 1Gx72 Module (2R x8)



NOTE:

- 1. Unless otherwise noted, resistor values are $15\Omega \pm 5\%$
- 2. See the net structure diagrams for resistors associated with the command, address and control bus.
- 3. ZQ resistors are $240\Omega\pm1\%$. For all other resistor values refer to the appropriate wiring diagram.



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11.AC&DC Operating Conditions

Recommended operating conditions (Voltage referred to Vss=0V, TA=0 to 70°C)

Symbol	Parameter	Min	Тур	Max	Unit
V_{DD}	Supply Voltage	1.14	1.2	1.26	V
V_{DDQ}	Supply Voltage for Output	1.14	1.2	1.26	V
V_{PP}		2.375	2.5	2.75	V

12. Input/Output Capacitance

Symbol	Doromot	DDR4	-2133	DDR4	-2400	Harit	NOTE	
Symbol	Paramet er	min	max	min	max	Unit	NOTE	
C_{IO}	Input/output capacitance	0.7	1.4	0.7	1.3	р	1,2,3	
C _{DIO}	Input/output capacitance delta	-0.1	0.1	-0.1	0.1	р	1,2,3,11	
C _{DDQS}	Input/output capacitance delta DQS_t and DQS_c	-	0.05	-	0.05	р	1,2,3,5	
C _{CK}	Input capacitance, CK_t and CK_c	0.2	0.8	0.2	0.7	р	1,3	
C _{DCK}	Input capacitance delta CK_t and CK_c	-	0.05	-	0.05	р	1,3,4	
C _I	Input capacitance(CTRL, ADD, CMD pins only)	0.2	0.8	0.2	0.7	р	1,3,6	
C _{DI_ CTRL}	Input capacitance delta(All CTRL pins only)	-0.1	0.1	-0.1	0.1	р	1,3,7,8	
C _{DI_ ADD_CMD}	Input capacitance delta(All ADD/CMD pins only)	-0.1	0.1	-0.1	0.1	р	1,2,9,10	
C _{ALERT}	Input/output capacitance of ALERT	0.5	1.5	0.5	1.5	р	1,3	
C_{ZQ}	Input/output capacitance of ZQ	0.5	2.3	0.5	2.3	р	1,3,12	
CTEN	Input capacitance of TEN	0.2	2.3	0.2	2.3	р	1,3,13	

Note:

- This parameter is not subject to production test. It is verified by design and characterization. The silicon only capacitance is validated by deembedding the package L & C parasitic. The capacitance is measured with VDD, VDDQ, VSS, VSSQ applied with all other signal pins floating. Measurement procedure TBD.
- 2. DQ, DM_n, DQS_T, DQS_C, TDQS_T, TDQS_C. Although the DM, TDQS_T and TDQS_C pins have different functions, the loading matches DQ and DQS
- 3. This parameter applies to monolithic devices only; stacked/dual-die devices are not covered here
- 4. Absolute value CK_T-CK_C
- 5. Absolute value of CIO(DQS_T)-CIO(DQS_c)
- 6. CI applies to ODT, CS_n, CKE, A0-A17, BA0-BA1, BG0-BG1, RAS_n/A16, CAS_n/A15, WE_n/A14, ACT_n and PAR.
- 7. CDI CTRL applies to ODT, CS_n and CKE
- 8. $CDI_CTRL = CI(CTRL)-0.5*(CI(CLK_T)+CI(CLK_C))$
- 9. CDI_ADD_ CMD applies to, A0-A17, BA0-BA1, BG0-BG1,RAS_n/A16, CAS_n/A15, WE_n/A14, ACT_n and PAR.
- 10. $CDI_ADD_CMD = CI(ADD_CMD) 0.5*(CI(CLK_T) + CI(CLK_C))$
- 11. $CDIO = CIO(DQ,DM)-0.5*(CIO(DQS_T)+CIO(DQS_c))$
- 12. Maximum external load capacitance on ZQ pin: tbd pF.
- 13. TEN pin may be DRAM internally pulled low through a weak pull-down resistor to VSS. In this case CTEN might not be valid and system shall verify TEN signal with Vendor specific information.



DDR4 SDRAM

13.AC Timing Parameters & Specifications(AC operating conditions unless otherwise noted)

Speed		DDR4-1	866	DDR4-2133		DDR4-240	Units	NOTE	
Parameter	Symbol	MIN	MAX	MIN	MAX	MIN	MAX	Oillis	NOIL
Clock Timing									
Minimum Clock Cycle Time (DLL off mode)	tCK (DLL_OFF)	8	-	8	-	8	-	ns	22
Average Clock Period	tCK(avg)	1.071	<1.25	0.938	<1.071	0.833	<0.938	ns	35,36
Average high pulse width	tCH(avg)	0.48	0.52	0.48	0.52	0.48	0.52	tCK(avg)	
Average low pulse width	tCL(avg)	0.48	0.52	0.48	0.52	0.48	0.52	tCK(avg)	
Absolute Clock Period	tCK(abs)	tCK(avg)min + tJIT(per)min_ to t	tCK(avg)m ax + tJIT(per)m ax_tot	tCK(avg)min + tJIT(per)min_ to t	tCK(avg)m ax + tJIT(per)m ax_tot	tCK(avg)min + tJIT(per)min _to t	tCK(avg)m ax + tJIT(per)m ax_tot	tCK(avg)	
Absolute clock HIGH pulse width	tCH(abs)	0.45	-	0.45	-	0.45	-	tCK(avg)	23
Absolute clock LOW pulse width	tCL(abs)	0.45	-	0.45	-	0.45	-	tCK(avg)	24
Clock Period Jitter- total	JIT(per)_tot	-54	54	-47	47	-42	42	ps	23
Clock Period Jitter- deterministic	JIT(per)_dj	-27	27	-23	23	-21	21	ps	26
Clock Period Jitter during DLL locking period	tJIT(per, lck)	-43	43	-38	38	-33	33	ps	
Cycle to Cycle Period Jitter	tJIT(cc)_tota I	1	07	9	4		33	ps	25
Cycle to Cycle Period Jitter deterministic	tJIT(cc)_dj		54		7		12	ps	26
Cycle to Cycle Period Jitter during DLL locking period	tJIT(cc, lck)	8	36	7	5	67		ps	
Duty Cycle Jitter	tJIT(duty)	TBD	TBD	TBD	TBD	TBD	TBD	ps	
Cumulative error across 2 cycles	tERR(2per)	-79	79	-69	69	-61	61	ps	
Cumulative error across 3 cycles	tERR(3per)	-94	94	-82	82	-73	73	ps	
Cumulative error across 4 cycles	tERR(4per)	-104	104	-91	91	-81	81	ps	
Cumulative error across 5 cycles	tERR(5per)	-112	112	-98	98	-87	87	ps	
Cumulative error across 6 cycles	tERR(6per)	-119	119	-104	104	-92	92	ps	
Cumulative error across 7 cycles	tERR(7per)	-124	124	-109	109	-97	97	ps	
Cumulative error across 8 cycles	tERR(8per)	-129	129	-113	113	-101	101	ps	
Cumulative error across 9 cycles	tERR(9per)	-134	134	-117	117	-104	104	ps	
Cumulative error across 10 cycles	tERR(10per)	-137	137	-120	120	-107	107	ps	
Cumulative error across 11 cycles	tERR(11per)	-141	141	-123	123	-110	110	ps	
Cumulative error across 12 cycles	tERR(12per)	-144	144	-126	126	-112	112	ps	
Cumulative error across 13 cycles	tERR(13per)	-147	147	-129	129	-114	114	ps	
Cumulative error across 14 cycles	tERR(14per)	-150	150	-131	131	-116	116	ps	
Cumulative error across 15 cycles	tERR(15per)	-152	152	-133	133	-118	118	ps	
Cumulative error across 16 cycles	tERR(16per)	-155	155	-135	135	-120	120	ps	
Cumulative error across 17 cycles	tERR(17per)	-157	157	-137	137	-122	122	ps	
Cumulative error across 18 cycles	tERR(18per)	-159	159	-139	139	-124	124	ps	
Cumulative error across n = 13, 14 49, 50 cycles	tERR(nper)	¹ ERR(nper)min = ((1 + 0.68ln(n)) * ¹ JIT(per)_total min) ¹ ERR(nper)max = ((1 + 0.68ln(n)) * ¹ JIT(per)_total max)						ps	
Command and Address setup time to CK_t, creferenced to Vih(ac) / Vil(ac) levels	tIS(base)	100	-	80	-	62	-	ps	
Command and Address setup time to CK_t, CK_c referenced to Vref levels	tIS(Vref)	200	-	180	-	162	-	ps	
Command and Address hold time to CK_t, CK_c referenced to Vih(dc) / Vil(dc) levels	tIH(base)	125	-	105	-	87	-	ps	



Speed		DDR4-1866		DDR4-2133		DDR4-2400		Units	NOTE
Parameter	Symbol	MIN	MAX	MIN	MAX	MIN	MAX	Units	NOTE
Command and Address Timing									
Command and Address hold time to CK_t, CK_c referenced to Vref levels	tIH(Vref)	200	-	180	-	162	-	ps	
Control and Address Input pulse width for each input	tIPW	525	-	460	-	410	-	ps	
CAS_n to CAS_n command delay for same bank group	tCCD_L	5	-	6	-	6	-	nCK	34
CAS_n to CAS_n command delay for different bank group	tCCD_S	4	-	4	-	4	-	nCK	34
ACTIVATE to ACTIVATE Command delay to different bank group for 2KB page size	tRRD_S(2K)	Max(4nCK,5. 3ns)	-	Max(4nCK,5. 3ns)	-	Max(4nCK,5 .3ns)	-	nCK	34
ACTIVATE to ACTIVATE Command delay to different bank group for 2KB page size	tRRD_S(1K)	Max(4nCK,4. 2ns)	-	Max(4nCK,3. 7ns)	-	Max(4nCK,3 .3ns)	-	nCK	34
ACTIVATE to ACTIVATE Command delay to different bank group for 1/ 2KB page size	tRRD_S(1/2K)	Max(4nCK,4. 2ns)	-	Max(4nCK,3. 7ns)	-	Max(4nCK,3 .3ns)	-	nCK	34
ACTIVATE to ACTIVATE Command delay to same bank group for 2KB page size	tRRD_L(2K)	Max(4nCK,6. 4ns)	-	Max(4nCK,6. 4ns)	-	Max(4nCK,6 .4ns)	-	nCK	34
ACTIVATE to ACTIVATE Command delay to same bank group for 1KB page size	tRRD_L(1K)	Max(4nCK,5. 3ns)	-	Max(4nCK,5. 3ns)	-	Max(4nCK,4 .9ns)	-	nCK	34
ACTIVATE to ACTIVATE Command delay to same bank group for 1/2KB page size	tRRD_L(1/2K)	Max(4nCK,5. 3ns)	-	Max(4nCK,5. 3ns)	-	Max(4nCK,4 .9ns)	-	nCK	34
Four activate window for 2KB page size	tFAW_2K	Max(28nCK,3 0ns)	-	Max(28nCK,3 0ns)	-	Max(28nCK, 30ns)	-	ns	34
Four activate window for 1KB page size	tFAW_1K	Max(20nCK,2 3ns)	-	Max(20nCK,2 1ns)	-	Max(20nCK, 21ns)	-	ns	34
Four activate window for 1/2KB page size	tFAW_1/2K	Max(16nCK,1 7ns)	-	Max(16nCK,1 5ns)	-	Max(16nCK, 13ns)	-	ns	34
Delay from start of internal write trans- action to internal read command for different bank group	tWTR_S	max(2nCK,2. 5ns)	-	max(2nCK,2. 5ns)	-	max (2nCK, 2.5ns)	-		1,2,e,3 4
Delay from start of internal write trans- action to internal read command for same bank group	tWTR_L	max(4nCK,7. 5ns)	-	max(4nCK,7. 5ns)	-	max (4nCK,7.5ns)	-		1,34
Internal READ Command to PRE- CHARGE Command delay	tRTP	max(4nCK,7. 5ns)	-	max(4nCK,7. 5ns)	-	max (4nCK,7.5ns	-		
WRITE recovery time	tWR	15	-	15	-	15	-	ns	1
Write recovery time when CRC and DM are enabled	tWR_CRCDM	tWR+max (5nCK,3.75ns)	-	tWR+max (5nCK,3.75ns	-	tWR+max (5nCK,3.75n s)	-	ns	1, 28
delay from start of internal write trans- action to internal read command for different bank group with both CRC and DM enabled	tWTR_S_C RC_DM	tWTR_S+ma x (5nCK,3.75ns)	-	tWTR_S+ma x (5nCK,3.75ns)	-	tWTR_S+m ax (5nCK,3.75n s)	-	ns	2, 29, 34
delay from start of internal write trans- action to internal read command for same bank group with both CRC and DM enabled	tWTR_L_C RC_DM	tWTR_L+max (5nCK,3.75ns)	-	tWTR_L+max (5nCK,3.75ns	-	tWTR_L+m ax (5nCK,3.75n s)	-	ns	3,30, 34
DLL locking time	tDLLK	597	-	768	-	768	-	nCK	
Mode Register Set command cycle time	tMRD	8	-	8	-	8	-	nCK	
Mode Register Set command update delay	tMOD	max(24nCK,1 5ns)	-	max(24nCK,1 5ns)	-	max(24nCK, 15ns)	-		
Multi-Purpose Register Recovery Time	tMPRR	1	-	1	-	1	-	nCK	33
Multi Purpose Register Write Recovery Time	tWR_MPR	tMOD (min) + AL + PL	-	tMOD (min) + AL + PL	-	tMOD (min) + AL + PL	-	-	
Auto precharge write recovery + precharge time	tDAL(min) Programmed WR + roundup (tRP / tCK(avg))								
CS_n to Command Address Latency									
CS_n to Command Address Latency	tCAL			4	1			-	4



MAX	Speed		DDR4-1866		DDR4-2133		DDR4-2400		Unite	NOTE
10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.00 10.0	Parameter	Symbol	MIN	MAX	MIN	MAX	MIN	MAX	Units	NOTE
Section Sect	DRAM Data Timing									
Per group, per access 1.50-0.00 TBD -	DQS_t,DQS_c to DQ skew, per group, per access	tDQSQ	-	TBD	-	TBD	-	TBD		13,18
DOS.1.DOS.c DOS.c	DQS_t,DQS_c to DQ Skew determin- istic, per group, per access	tDQSQ	-	TBD	-	TBD	-	TBD		
Trans DGS_LDGS_color Transparent Trans	DQ output hold time from DQS_t,DQS_c	tQH	TBD	-	TBD	-	TBD	-		
group, per access; DBI enabled	DQ output hold time deterministic from DQS_t, DQS_c	tQH	TBD	-	TBD	-	TBD	-	UI	
DOS_COS Francisco DOS_COS DO	DQS_t,DQS_c to DQ Skew total, per group, per access; DBI enabled	tDQSQ	-	TBD	-	TBD	-	TBD	UI	13,19
Dos. Dos. Code Dos.	DQ output hold time total from DQS_t, DQS_c; DBI enabled	tQH	TBD	-	TBD	-	TBD	-	UI	13,19
DGS_L_DGS_c differential READ Pre- amble (2 does presentable) IRPRE	DQ to DQ offset , per group, per access referenced to DQS_t, DQS_c	tDQSQ	TBD	TBD	TBD	TBD	TBD	TBD	UI	15,16
amble (2 dock preamble)	Data Strobe Timing									
Postamble	DQS_t, DQS_c differential READ Preamble (2 clock preamble)	tRPRE	0.9	TBD	0.9	TBD	0.9	TBD	tCK	
DQS_t_DQS_c_differential output low time tQSL 0.4 . 0.4 . 0.4 . 0.4 . 10.4 . 10.4 . 10.5 20 DQS_t_DQS_c_differential WRITE tWPRE 0.9 . 0.9 . 0.9 . 0.9 . 10.9 . 10.5 DQS_t_DQS_c_differential WRITE tWPRE 0.9 . 0.9 . 0.9 . 10.9 . 10.5 DQS_t_DQS_c_differential WRITE tWPST TBD T	DQS_t, DQS_c differential READ Postamble	tRPST	TBD	TBD	TBD	TBD	TBD	TBD	tCK	
DOS_t_DOS_c differential WRITE tWPRE 0.9 0.9 0.9	DQS_t,DQS_c differential output high time	tQSH	0.4	-	0.4	-	0.4	-	tCK	21
Preamble	DQS_t,DQS_c differential output low time	tQSL	0.4	-	0.4	-	0.4	-	tCK	20
Postamble	DQS_t, DQS_c differential WRITE Preamble	tWPRE	0.9	-	0.9	-	0.9	-	tCK	
Referenced from RL-1 REZ(DQS) 193 195 190 190 190 195 190 195 190 195 190 195 190 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195 195	DQS_t, DQS_c differential WRITE Postamble	tWPST	TBD	TBD	TBD	TBD	TBD	TBD	tCK	
CREferenced from RL+BL/2 CREST	DQS_t and DQS_c low-impedance time (Referenced from RL-1)	tLZ(DQS)	-390	195	-360	180	-300	150	ps	
pulse width IDGSL 0.46 0.34 0.46 0.54 0.46 0.54 0.46 0.54 0.46 0.54 0.46 0.54 1CK 0.54 1CK 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.28 0.28 0.28	DQS_t and DQS_c high-impedance time (Referenced from RL+BL/2)	tHZ(DQS)	-	195	-	180	-	150	ps	
pulse width LDQSH 0.46 0.34 0.46 0.34 0.46 0.34 0.46 0.34 0.46 0.34 0.46 0.34 0.46 0.34 0.46 0.34 0.46 0.34 0.46 0.34 0.46 0.34 0.46 0.34 0.46 0.34 0.46 0.34 0.48 0.48 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.27 0.28 0.28 0.28	DQS_t, DQS_c differential input low pulse width	tDQSL	0.46	0.54	0.46	0.54	0.46	0.54	tCK	
CK_c rising edge (1 clock preamble)	DQS_t, DQS_c differential input high pulse width	tDQSH	0.46	0.54	0.46	0.54	0.46	0.54	tCK	
DQS_t, DQS_c falling edge hold time from CK_t, CK_c rising edge tDSH 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 - 0.18 -	DQS_t, DQS_c rising edge to CK_t, CK_c rising edge (1 clock preamble)	tDQSS	-0.27	0.27	-0.27	0.27	-0.27	0.27	tCK	
MPSM Timing MPSM Timing MPED MOD(min) +	DQS_t, DQS_c falling edge setup time to CK_t, CK_c rising edge	tDSS	0.18	-	0.18	-	0.18	-	tCK	
Command path disable delay upon MPED MPED MPED MOD(min) + tCPDED(min) MOD(min) + tCP- DED(min)	DQS_t, DQS_c falling edge hold time from CK_t, CK_c rising edge	tDSH	0.18	-	0.18	-	0.18	-	tCK	
Command path disable delay upon MPSM entry tMPED tMOD(min) + tCPDED(min) - tCPDED(min) <t< td=""><td>MPSM Timing</td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td></t<>	MPSM Timing									
/alid clock requirement after MPSM entry /alid clock requirement before MPSM exit /alid clock requirement after MPSM ex	Command path disable delay upon MPSM entry	tMPED		-		-		-		
//alid clock requirement before MPSM exit tCKMPX tCKSRX(min) tCKSRX(min) - - - Exit MPSM to commands not requir- ing a locked DLL tXMP TBD TBD TBD - TBD - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - - <t< td=""><td>Valid clock requirement after MPSM entry</td><td>tCKMPE</td><td>tMOD(min) +</td><td>-</td><td>tMOD(min) +</td><td>-</td><td></td><td>-</td><td></td><td></td></t<>	Valid clock requirement after MPSM entry	tCKMPE	tMOD(min) +	-	tMOD(min) +	-		-		
Exit MPSM to commands not requir- ing a locked DLL tXMP TBD TBD TBD - Exit MPSM to commands requiring a locked DLL tXMP(min) + tXSPLL(min) tXMP(min) + tXSPLL(min) tXMP(min) + tXSPLL(min) - - CS setup time to CKE tMPX_S TBD - TBD - TBD - -	Valid clock requirement before MPSM exit	tCKMPX					tCK- SRX(min)	-	1	
EXIMPSMI to Confirmation requiring a tXMPDLL tXMP(nim) + tXSDLL(min) tXSDLL(min) -	Exit MPSM to commands not requir- ing a locked DLL		` ′		` '		TBD	-		
CS setup time to CKE tMPX_S TBD - TBD - TBD -	Exit MPSM to commands requiring a locked DLL	tXMPDLL						-		
CS hold time to CKE tMPX_H TBD - TBD - TBD -		tMPX_S		-	, ,	-	TBD	-	1	
	CS hold time to CKE	tMPX_H	TBD	-	TBD	-	TBD	-		



Speed		DDR4-1866		DDR4-2133		DDR4-2400		Units	NOTE
Parameter	Symbol	MIN	MAX	MIN	MAX	MIN	MAX	Units	NOIE
Calibration Timing				1		1	l .	-1	I
Power-up and RESET calibration time	tZQinit	1024	-	1024	-	1024	-	nCK	
Normal operation Full calibration time	tZQoper	512	-	512	-	512	-	nCK	
Normal operation Short calibration time	tZQCS	128	-	128	-	128	-	nCK	
Reset/Self Refresh Timing							•		
Exit Reset from CKE HIGH to a valid	tXPR	max (5nCK,tRFC(_	max (5nCK,tRFC(min)+	_	max (5nCK.tRFC	_		
Exit Self Refresh to commands not requiring a locked DLL	tXS	tRFC(min)+1 0ns	-	tRFC(min)+1 0ns	-	tRFC(min)+ 10ns	-		
SRX to commands not requiring a locked DLL in Self Refresh ABORT	tXS_ABORT (min)	tRFC4(min)+ 10ns	-	tRFC4(min)+ 10ns	-	tRFC4(min) +10ns	-		
Exit Self Refresh to ZQCL,ZQCS and MRS (CL,CWL,WR,RTP and Gear Down)	tXS_FAST (min)	tRFC4(min)+	-	tRFC4(min)+	-	tRFC4(min)	-		
Exit Self Refresh to commands requir- ing a locked DLL	tXSDLL	tDLLK(min)	-	tDLLK(min)	-	tDLLK(min)	-		
Minimum CKE low width for Self re- fresh entry to exit timing	tCKESR	tCKE(min)+1 nCK	-	tCKE(min)+1 nCK	-	tCKE(min)+ 1nCK	-		
Minimum CKE low width for Self re- fresh entry to exit timing with CA Parity enabled	tCKESR_ PAR	tCKE(min)+ 1nCK+PL	-	tCKE(min)+ 1nCK+PL	-	tCKE(min)+ 1nCK+PL	-		
Valid Clock Requirement after Self Refresh Entry (SRE) or Power-Down Entry (PDE)	tCKSRE	max(5nCK,10 ns)	-	max(5nCK,10 ns)	-	max (5nCK,10ns)	-		
Valid Clock Requirement after Self Refresh Entry (SRE) or Power-Down when CA Parity is enabled	tCKSRE_PA R	max (5nCK,10ns) +PL	-	max (5nCK,10ns) +PL	-	max (5nCK,10ns) +PL	-		
Valid Clock Requirement before Self Refresh Exit (SRX) or Power-Down Exit (PDX) or Reset Exit	tCKSRX	max(5nCK,10 ns)	-	max(5nCK,10 ns)	-	max (5nCK,10ns)	-		
Power Down Timing								•	
Exit Power Down with DLL on to any valid command;Exit Precharge Power Down with DLL frozen to commands not requiring a locked DLL	tXP	max (4nCK,6ns)	-	max (4nCK,6ns)	-	max (4nCK,6ns)	-		
CKE minimum pulse width	tCKE	max (3nCK, 5ns)	-	max (3nCK, 5ns)	-	max (3nCK, 5ns)	-		31,32
Command pass disable delay	tCPDED	4	-	4	-	4	-	nCK	
Power Down Entry to Exit Timing	tPD	tCKE(min)	9*tREFI	tCKE(min)	9*tREFI	tCKE(min)	9*tREFI		6
Timing of ACT command to Power Down entry	tACTPDEN	1	-	2	-	2	-	nCK	7
Timing of PRE or PREA command to Power Down entry	tPRPDEN	1	-	2	-	2	-	nCK	7
Timing of RD/RDA command to Power Down entry	tRDPDEN	RL+4+1	-	RL+4+1	-	RL+4+1	-	nCK	
Timing of WR command to Power Down entry (BL8OTF, BL8MRS, BC4OTF)	tWRPDEN	WL+4+(tWR/ tCK(avg))	-	WL+4+(tWR/ tCK(avg))	-	WL+4+(tWR /tCK(avg))	-	nCK	4
Timing of WRA command to Power Down entry (BL8OTF, BL8MRS, BC4OTF)	tWRAPDEN	WL+4+WR+1	-	WL+4+WR+1	-	WL+4+WR+ 1	-	nCK	5
Timing of WR command to Power Down entry (BC4MRS)	tWRPBC4D EN	WL+2+(tWR/ tCK(avg))	-	WL+2+(tWR/ tCK(avg))	-	WL+2+(tWR /tCK(avg))	-	nCK	4
Timing of WRA command to Power Down entry (BC4MRS)	tWRAPBC4 DEN	WL+2+WR+1	-	WL+2+WR+1	-	WL+2+WR+ 1	-	nCK	5
Timing of REF command to Power Down entry	tREFPDEN	1	-	2	_	2	-	nCK	7
•	L	l	L			1	L	1	L



Speed		DDR4-1866		DDR4-2133		DDR4-2400		Unite	NOTE
Parameter	Symbol	MIN	MAX	MIN	MAX	MIN	MAX	linite	NOTE
Timing of MRS command to Power		(1405(:)		(1107(;)		(1100(;)			
Down entry PDA Timing	tMRSPDEN	tMOD(min)	-	tMOD(min)	-	tMOD(min)	-		
Mode Register Set command cycle time in PDA mode	tMRD_PDA	max(16nCK,1 0ns)		max(16nCK,1 0ns)		max(16nCK, 10ns)			
Mode Register Set command update	tMOD_PDA		OD	tMOD		tMO	D		
delay in PDA mode ODT Timing									
Asynchronous RTT turn-on delay (Power-Down with DLL frozen)	tAONAS	1.0	9.0	1.0	9.0	1.0	9.0	ns	
Asynchronous RTT turn-off delay (Power-Down with DLL frozen)	tAOFAS	1.0	9.0	1.0	9.0	1.0	9.0	ns	
RTT dynamic change skew	tADC	0.3	0.7	0.3	0.7	0.3	0.7	tCK(avg)	
Write Leveling Timing	l.				1				
First DQS_t/DQS_n rising edge after	tWLMRD	40	_	40	_	40	_	nCK	12
write leveling mode is programmed DQS_t/DQS_n delay after write level-ing mode is programmed	tWLDQSEN	25	-	25	-	25	-	nCK	12
Write leveling setup time from rising CK_t, CK c crossing to rising DQS t/ DQS n	tWLS	0.13	-	0.13	-	0.13	-	tCK(avg)	
Write leveling hold time from rising DQS t/DQS n crossing to rising CK t,	tWLH	0.13	_	0.13	_	0.13	_	tCK(avg)	
Write leveling output delay	tWLO	0.13	9.5	0.13	9.5	0	9.5	ns	
Write leveling output error	tWLOE							ns	
CA Parity Timing	l		l						
Commands not guaranteed to be executed during this time	tPAR_UNKN OWN	-	PL	-	PL	-	PL		
Delay from errant command to ALERT_n assertion	tPAR_ALER	_	PL+6ns	_	PL+6ns	_	PL+6ns		
Pulse width of ALERT_n signal when asserted	tPAR_ALER T_PW	56	112	64	128	72	144	nCK	
Time from when Alert is asserted till controller must start providing DES commands in Persistent CA parity mode	tPAR_ALER T_RSP	-	50	-	57	-	64	nCK	
Parity Latency	PL		4		4	5		nCK	
CRC Error Reporting								L	
CRC error to ALERT_n latency	tCRC_ALER T	3	13	3	13	3	13	ns	
CRC ALERT_n pulse width	CRC_ALER T_PW	6	10	6	10	6	10	nCK	
tREFI									
	2Gb	160	-	160	-	160	-	ns	34
	4Gb	260	-	260	-	260	-	ns	34
tRFC1 (min)	8Gb	350	-	350	-	350	-	ns	34
	16Gb	TBD	-	TBD	-	TBD	-	ns	34
	2Gb	110	-	110	-	110	-	ns	34
	4Gb	160	-	160	-	160	-	ns	34
tRFC2 (min)	8Gb	260	-	260	-	260	-	ns	34
	16Gb	TBD	-	TBD	-	TBD	-	ns	34
	2Gb	90	-	90	-	90	-	ns	34
	4Gb	110	-	110	-	110	-	ns	34
tRFC4 (min)	8Gb	160	-	160	-	160	-	ns	34
	16Gb	TBD	-	TBD	-	TBD	-	ns	34



DDR4 SDRAM

Note:

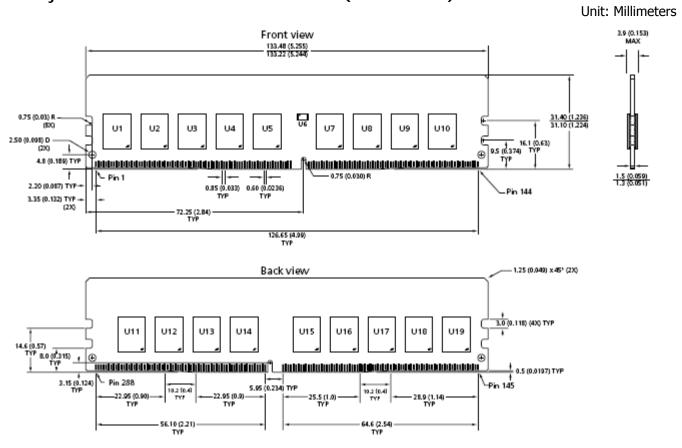
- 1. Start of internal write transaction is defined as follows:
 - For BL8 (Fixed by MRS and on-the-fly): Rising clock edge 4 clock cycles after WL. For BC4 (on-the-fly): Rising clock edge 4 clock cycles after WL. For BC4 (fixed by MRS): Rising clock edge 2 clock cycles after WL.
- 2. A separate timing parameter will cover the delay from write to read when CRC and DM are simultaneously enabled
- 3. Commands requiring a locked DLL are: READ (and RAP) and synchronous ODT commands.
- 4. tWR is defined in ns, for calculation of tWRPDEN it is necessary to round up tWR/tCK to the next integer.
- WR in clock cycles as programmed in MR0.
- tREFI depends on TOPER.
- CKE is allowed to be registered low while operations such as row activation, precharge, autoprecharge or refresh are in progress, but power-down
- IDD spec will not be applied until finishing those operations.

 8. For these parameters, the DDR4 SDRAM device supports tnPARAM[nCK]=RU{tPARAM[ns]/tCK(avg)[ns]}, which is in clock cycles assuming all input clock jitter specifications are satisfied
- 9. When CRC and DM are both enabled, tWR_CRC_DM is used in place of tWR.
- 10. When CRC and DM are both enabled tWTR_S_CRC_DM is used in place of tWTR_S.
- 11. When CRC and DM are both enabled tWTR_L_CRC_DM is used in place of tWTR_L.
- 12. The max values are system dependent.
- 13. DQ to DQS total timing per group where the total includes the sum of deterministic and random timing terms for a specified BER. BER spec and measurement method are tbd.
- 14. The deterministic component of the total timing. Measurement method tbd.
- 15. DQ to DQ static offset relative to strobe per group. Measurement method tbd.
- 16. This parameter will be characterized and guaranteed by design.
- 17. When the device is operated with the input clock jitter, this parameter needs to be derated by the actual tjit(per)_total of the input clock. (output deratings are relative to the SDRAM input clock). Example tbd.
- 18. DRAM DBI mode is off.
- 19. DRAM DBI mode is enabled. Applicable to x8 and x16 DRAM only.
- 20. tQSL describes the instantaneous differential output low pulse width on DQS_t DQS_c, as measured from on falling edge to the next consecutive rising edge
- 21. tQSH describes the instantaneous differential output high pulse width on DQS_t DQS_c, as measured from on falling edge to the next consecutive rising edge
- 22. There is no maximum cycle time limit besides the need to satisfy the refresh interval tREFI
- 23. tCH(abs) is the absolute instantaneous clock high pulse width, as measured from one rising edge to the following falling edge
- 24. tCL(abs) is the absolute instantaneous clock low pulse width, as measured from one falling edge to the following rising edge
- 25. Total jitter includes the sum of deterministic and random jitter terms for a specified BER. BER target and measurement method are tbd.
- 26. The deterministic jitter component out of the total jitter. This parameter is characterized and gauranteed by design.
- 27. This parameter has to be even number of clocks
- 28. When CRC and DM are both enabled, tWR_CRC_DM is used in place of tWR.
- 29. When CRC and DM are both enabled tWTR_S_CRC_DM is used in place of tWTR_S.
- 30. When CRC and DM are both enabled $tWTR_L_CRC_DM$ is used in place of $tWTR_L$.
- 31. After CKE is registered LOW, CKE signal level shall be maintained below VILDC for tCKE specification (Low pulse width).
- 32. After CKE is registered HIGH, CKE signal level shall be maintained above VIHDC for tCKE specification (HIGH pulse width).
- 33. Defined between end of MPR read burst and MRS which reloads MPR or disables MPR function.
- 34. Parameters apply from tCK(avg)min to tCK(avg)max at all standard JEDEC clock period values as stated in the Speed Bin Tables.
- 35. This parameter must keep consistency with Speed-Bin Tables shown in section 10.
- 36. DDR4-1600 AC timing apply if DRAM operates at lower than 1600 MT/s data rate. UI=tCK(avg).min/2



DDR4 SDRAM

14. Physical Dimensions: 1Gx72 Dual Rank x8 (512Mx8 base)



^{*} NOTE : Tolerances on all dimensions ±0.15 unless otherwise specified.